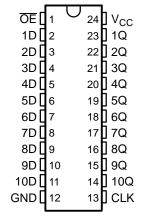
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#### **FEATURES**

- Operates From 1.65 V to 3.6 V
- Inputs Accept Voltages to 5.5 V
- Max t<sub>pd</sub> of 7.3 ns at 3.3 V
- Typical V<sub>OLP</sub> (Output Ground Bounce)
   <0.8 V at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C
- Typical V<sub>OHV</sub> (Output V<sub>OH</sub> Undershoot)
   >2 V at V<sub>CC</sub> = 3.3 V, T<sub>A</sub> = 25°C
- Supports Mixed-Mode Signal Operation on All Ports (5-V Input/Output Voltage With 3.3-V V<sub>CC</sub>)
- I<sub>off</sub> Supports Partial-Power-Down Mode Operation
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds JESD 22
  - 2000-V Human-Body Model (A114-A)

# DB, DGV, DW, NS, OR PW PACKAGE (TOP VIEW)



#### **DESCRIPTION/ORDERING INFORMATION**

This 10-bit bus-interface flip-flop is designed for 1.65-V to 3.6-V V<sub>CC</sub> operation.

The SN74LVC821A features 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. This device is particularly suitable for implementing wider buffer registers, I/O ports, bidirectional bus drivers with parity, and working registers.

The ten flip-flops are edge-triggered D-type flip-flops. On the positive transition of the clock (CLK) input, the device provides true data at the Q outputs.

A buffered output-enable  $(\overline{OE})$  input can be used to place the ten outputs in either a normal logic state (high or low logic levels) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without interface or pullup components.

OE does not affect the internal operations of the latch. Previously stored data can be retained or new data can be entered while the outputs are in the high-impedance state.

#### **ORDERING INFORMATION**

T <sub>A</sub>	PACK	AGE <sup>(1)</sup>	ORDERABLE PART NUMBER	TOP-SIDE MARKING	
	SOIC - DW	Tube of 25	SN74LVC821ADW	LVC821A	
	SOIC - DW	Reel of 2000	SN74LVC821ADWR	LVC021A	
	SOP - NS	Reel of 2000	SN74LVC821ANSR	LVC821A	
–40°C to 85°C	SSOP - DB	Reel of 2000	SN74LVC821ADBR	LC821A	
-40°C 10 65°C		Tube of 60	SN74LVC821APW		
	TSSOP - PW	Reel of 2000	SN74LVC821APWR	LC821A	
		Reel of 250	SN74LVC821APWT		
	TVSOP - DGV	Reel of 2000	SN74LVC821ADGVR	LC821A	

(1) Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.



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## **DESCRIPTION/ORDERING INFORMATION (CONTINUED)**

Inputs can be driven from either 3.3-V or 5-V devices. This feature allows the use of this device as a translator in a mixed 3.3-V/5-V system environment.

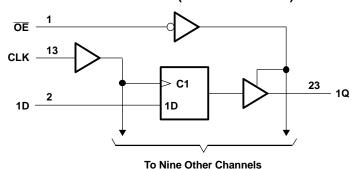
This device is fully specified for partial-power-down applications using  $I_{\text{off}}$ . The  $I_{\text{off}}$  circuitry disables the outputs, preventing damaging current backflow through the device when it is powered down.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

# FUNCTION TABLE (EACH FLIP-FLOP)

	INPUTS	OUTPUT	
ŌĒ	CLK	D	Q
L	1	Н	Н
L	$\uparrow$	L	L
L	H or L	Χ	$Q_0$
Н	X	Χ	Z

#### **LOGIC DIAGRAM (POSITIVE LOGIC)**







# Absolute Maximum Ratings<sup>(1)</sup>

over operating free-air temperature range (unless otherwise noted)

			MIN	MAX	UNIT
V <sub>CC</sub>	Supply voltage range		-0.5	6.5	V
VI	Input voltage range <sup>(2)</sup>		-0.5	6.5	V
Vo	Voltage range applied to any output in the h	Voltage range applied to any output in the high-impedance or power-off state (2)			
Vo	Voltage range applied to any output in the h	nigh or low state <sup>(2)(3)</sup>	-0.5	$V_{CC} + 0.5$	V
I <sub>IK</sub>	Input clamp current	V <sub>1</sub> < 0		-50	mA
I <sub>OK</sub>	Output clamp current	V <sub>O</sub> < 0		-50	mA
Io	Continuous output current		±50	mA	
	Continuous current through V <sub>CC</sub> or GND			±100	mA
		DB package		63	
		DGV package		86	
$\theta_{JA}$	Package thermal impedance (4)	DW package		46	°C/W
		NS package		65	
		PW package		88	
T <sub>stg</sub>	Storage temperature range		-65	150	°C

<sup>(1)</sup> Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

# Recommended Operating Conditions<sup>(1)</sup>

			MIN	MAX	UNIT	
V	Complexed to an	Operating	1.65	3.6	V	
$V_{CC}$	Supply voltage	Data retention only	1.5		V	
		$V_{CC} = 1.65 \text{ V to } 1.95 \text{ V}$ el input voltage $V_{CC} = 2.3 \text{ V to } 2.7 \text{ V}$				
$V_{IH}$	High-level input voltage				V	
		V <sub>CC</sub> = 2.7 V to 3.6 V	2			
		V <sub>CC</sub> = 1.65 V to 1.95 V		$0.35 \times V_{CC}$		
$V_{IL}$	Low-level input voltage	V <sub>CC</sub> = 2.3 V to 2.7 V		0.7	V	
		V <sub>CC</sub> = 2.7 V to 3.6 V		0.8		
VI	Input voltage		0	5.5	V	
V	Output valtage	High or low state	0	V <sub>CC</sub>	V	
V <sub>O</sub>	Output voltage	3-state	0	5.5	V	
		V <sub>CC</sub> = 1.65 V		-4		
	High lovel output ourrent	V <sub>CC</sub> = 2.3 V		-8	mA	
I <sub>OH</sub>	High-level output current	$V_{CC} = 2.7 \text{ V}$		-12	IIIA	
		$V_{CC} = 3 V$		-24		
		V <sub>CC</sub> = 1.65 V		4		
	Low lovel output ourrent	V <sub>CC</sub> = 2.3 V		8	A	
l <sub>OL</sub>	Low-level output current	V <sub>CC</sub> = 2.7 V		12	mA	
		V <sub>CC</sub> = 3 V		24		
Δt/Δν	Input transition rise or fall rate			10	ns/V	
T <sub>A</sub>	Operating free-air temperature		-40	85	°C	

<sup>(1)</sup> All unused inputs of the device must be held at V<sub>CC</sub> or GND to ensure proper device operation. Refer to the TI application report, *Implications of Slow or Floating CMOS Inputs*, literature number SCBA004.

<sup>(2)</sup> The input negative-voltage and output voltage ratings may be exceeded if the input and output current ratings are observed.

<sup>3)</sup> The value of V<sub>CC</sub> is provided in the recommended operating conditions table.

<sup>(4)</sup> The package thermal impedance is calculated in accordance with JESD 51-7.

# SN74LVC821A 10-BIT BUS-INTERFACE FLIP-FLOP WITH 3-STATE OUTPUTS

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#### **Electrical Characteristics**

over recommended operating free-air temperature range (unless otherwise noted)

P	ARAMETER	TEST C	ONDITIONS	V <sub>cc</sub>	MIN	TYP <sup>(1)</sup>	MAX	UNIT	
		$I_{OH} = -100 \ \mu A$		1.65 V to 3.6 V	V <sub>CC</sub> - 0.2				
		$I_{OH} = -4 \text{ mA}$		1.65 V	1.2				
\/		$I_{OH} = -8 \text{ mA}$		2.3 V	1.7			V	
V <sub>OH</sub>		I <sub>OH</sub> = -12 mA		2.7 V	2.2			V	
		1 <sub>OH</sub> = -12 IIIA		3 V	2.4				
		$I_{OH} = -24 \text{ mA}$		3 V	2.2				
		I <sub>OL</sub> = 100 μA		1.65 V to 3.6 V			0.2		
V <sub>OL</sub>		$I_{OL} = 4 \text{ mA}$		1.65 V			0.45		
		$I_{OL} = 8 \text{ mA}$		2.3 V			0.7	V	
		I <sub>OL</sub> = 12 mA		2.7 V			0.4		
		$I_{OL} = 24 \text{ mA}$		3 V			0.55		
I		$V_{I} = 0 \text{ to } 5.5 \text{ V}$		3.6 V			±5	μΑ	
I <sub>off</sub>		$V_I$ or $V_O = 5.5 \text{ V}$		0			±10	μΑ	
$I_{OZ}$		$V_0 = 0 \text{ to } 5.5 \text{ V}$		3.6 V			±10	μΑ	
		$V_I = V_{CC}$ or GND	I <sub>O</sub> = 0	3.6 V			10		
$I_{CC}$ 3.6 V $\leq$ V <sub>I</sub> $\leq$ 5.5 V <sup>(2)</sup>		$3.6 \text{ V} \le V_1 \le 5.5 \text{ V}^{(2)}$	10 = 0	3.0 V	10			μΑ	
$\Delta I_{CC}$		One input at V <sub>CC</sub> – 0.6 V,	Other inputs at $V_{CC}$ or GND	2.7 V to 3.6 V			500	μΑ	
C	Control inputs			3.3 V		5		pF	
C <sub>i</sub>	Data inputs	$V_I = V_{CC}$ or GND		3.3 V		4		ρι	
C <sub>o</sub>	·	$V_O = V_{CC}$ or GND		3.3 V		7		pF	

All typical values are at  $\rm V_{CC}$  = 3.3 V,  $\rm T_A$  = 25°C. This applies in the disabled state only.

#### **Timing Requirements**

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

		V <sub>CC</sub> = ± 0.1	1.8 V 5 V	V <sub>CC</sub> = ± 0.2	2.5 V 2 V	V <sub>CC</sub> =	2.7 V	V <sub>CC</sub> = 3 ± 0.3	3.3 V 3 V	UNIT
		MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
f <sub>clock</sub>	Clock frequency		(1)		(1)		150		150	MHz
t <sub>w</sub>	Pulse duration, CLK high or low	(1)		(1)		3.3		3.3		ns
t <sub>su</sub>	Setup time, data before CLK	(1)		(1)		1.9		1.9		ns
t <sub>h</sub>	Hold time, data after CLK	(1)		(1)		1.5		1.5		ns

<sup>(1)</sup> This information was not available at the time of publication.





### **Switching Characteristics**

over recommended operating free-air temperature range (unless otherwise noted) (see Figure 1)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	V <sub>CC</sub> = ± 0.1	$V_{CC}$ = 1.8 V $V_{CC}$ = 2.5 V $\pm$ 0.15 V $\pm$ 0.2 V		V <sub>CC</sub> = 2.7 V		V <sub>CC</sub> = 3.3 V ± 0.3 V		UNIT	
(INPOT)		(001701)	MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
f <sub>max</sub>			(1)		(1)		150		150		MHz
t <sub>pd</sub>	CLK	Q	(1)	(1)	(1)	(1)		8.5	2.2	7.3	ns
t <sub>en</sub>	ŌĒ	Q	(1)	(1)	(1)	(1)		8.8	1.3	7.6	ns
t <sub>dis</sub>	ŌĒ	Q	(1)	(1)	(1)	(1)		6.8	1.6	6.2	ns
t <sub>sk(o)</sub>										1	ns

<sup>(1)</sup> This information was not available at the time of publication.

#### **Operating Characteristics**

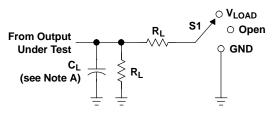
 $T_A = 25^{\circ}C$ 

	PARAMETER	TEST CONDITIONS	V <sub>CC</sub> = 1.8 V TYP	V <sub>CC</sub> = 2.5 V TYP	V <sub>CC</sub> = 3.3 V TYP	UNIT	
C	Power dissipation capacitance	Outputs enabled	f = 10 MHz	(1)	(1)	65	рF
C <sub>pd</sub>	per flip-flop	Outputs disabled	1 = 10 10172	(1)	(1)	48	рг

<sup>(1)</sup> This information was not available at the time of publication.



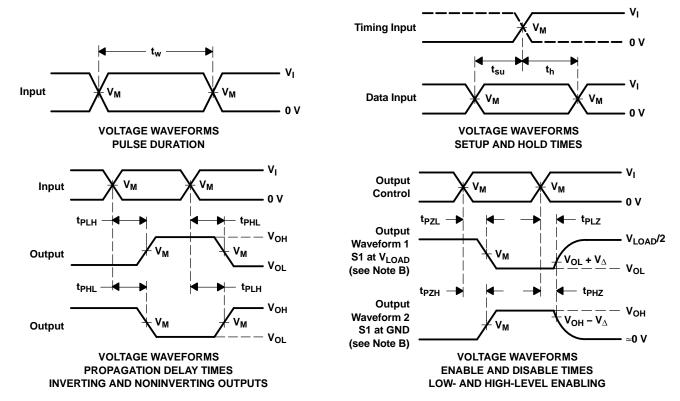
#### PARAMETER MEASUREMENT INFORMATION



TEST	S1
t <sub>PLH</sub> /t <sub>PHL</sub>	Open
t <sub>PLZ</sub> /t <sub>PZL</sub>	V <sub>LOAD</sub>
t <sub>PHZ</sub> /t <sub>PZH</sub>	GND

**LOAD CIRCUIT** 

v	INF	PUTS	.,	V	•		\ \ \
V <sub>CC</sub>	VI	t <sub>r</sub> /t <sub>f</sub>	V <sub>M</sub>	V <sub>LOAD</sub>	CL	R <sub>L</sub>	$V_{\Delta}$
1.8 V ± 0.15 V	V <sub>CC</sub>	≤2 ns	V <sub>CC</sub> /2	2×V <sub>CC</sub>	30 pF	<b>1 k</b> Ω	0.15 V
2.5 V $\pm$ 0.2 V	V <sub>CC</sub>	≤2 ns	V <sub>CC</sub> /2	2×V <sub>CC</sub>	30 pF	500 Ω	0.15 V
2.7 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	500 Ω	0.3 V
3.3 V $\pm$ 0.3 V	2.7 V	≤2.5 ns	1.5 V	6 V	50 pF	500 Ω	0.3 V



NOTES: A.  $C_L$  includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR ≤ 10 MHz, Z<sub>O</sub> = 50 Ω.
- D. The outputs are measured one at a time, with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$ .
- F. t<sub>PZL</sub> and t<sub>PZH</sub> are the same as t<sub>en</sub>.
- G. t<sub>PLH</sub> and t<sub>PHL</sub> are the same as t<sub>pd</sub>.
- H. All parameters and waveforms are not applicable to all devices.

Figure 1. Load Circuit and Voltage Waveforms

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#### PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
SN74LVC821ADBR	ACTIVE	SSOP	DB	24	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LC821A	Samples
SN74LVC821ADBRG4	ACTIVE	SSOP	DB	24	2000	TBD	Call TI	Call TI	-40 to 85		Samples
SN74LVC821ADGVR	ACTIVE	TVSOP	DGV	24	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LC821A	Samples
SN74LVC821ADW	ACTIVE	SOIC	DW	24	25	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVC821A	Samples
SN74LVC821ADWG4	ACTIVE	SOIC	DW	24	25	TBD	Call TI	Call TI	-40 to 85		Samples
SN74LVC821ADWR	ACTIVE	SOIC	DW	24	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LVC821A	Samples
SN74LVC821APW	ACTIVE	TSSOP	PW	24	60	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LC821A	Samples
SN74LVC821APWR	ACTIVE	TSSOP	PW	24	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LC821A	Samples
SN74LVC821APWRE4	ACTIVE	TSSOP	PW	24	2000	TBD	Call TI	Call TI	-40 to 85		Samples
SN74LVC821APWT	ACTIVE	TSSOP	PW	24	250	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 85	LC821A	Samples

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

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Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

<sup>(3)</sup> MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

<sup>(4)</sup> There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.



# **PACKAGE OPTION ADDENDUM**

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(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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# **PACKAGE MATERIALS INFORMATION**

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#### TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74LVC821ADBR	SSOP	DB	24	2000	330.0	16.4	8.2	8.8	2.5	12.0	16.0	Q1
SN74LVC821ADGVR	TVSOP	DGV	24	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74LVC821ADWR	SOIC	DW	24	2000	330.0	24.4	10.75	15.7	2.7	12.0	24.0	Q1
SN74LVC821APWR	TSSOP	PW	24	2000	330.0	16.4	6.95	8.3	1.6	8.0	16.0	Q1
SN74LVC821APWT	TSSOP	PW	24	250	330.0	16.4	6.95	8.3	1.6	8.0	16.0	Q1



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#### \*All dimensions are nominal

7 til dillionsions die nominal							
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74LVC821ADBR	SSOP	DB	24	2000	356.0	356.0	35.0
SN74LVC821ADGVR	TVSOP	DGV	24	2000	356.0	356.0	35.0
SN74LVC821ADWR	SOIC	DW	24	2000	350.0	350.0	43.0
SN74LVC821APWR	TSSOP	PW	24	2000	356.0	356.0	35.0
SN74LVC821APWT	TSSOP	PW	24	250	356.0	356.0	35.0

# **PACKAGE MATERIALS INFORMATION**

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#### **TUBE**



#### \*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
SN74LVC821ADW	DW	SOIC	24	25	506.98	12.7	4826	6.6
SN74LVC821APW	PW	TSSOP	24	60	530	10.2	3600	3.5

#### DGV (R-PDSO-G\*\*)

#### **24 PINS SHOWN**

#### **PLASTIC SMALL-OUTLINE**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.

D. Falls within JEDEC: 24/48 Pins – MO-153 14/16/20/56 Pins – MO-194 DW (R-PDSO-G24)

## PLASTIC SMALL OUTLINE



NOTES: A. All linear dimensions are in inches (millimeters). Dimensioning and tolerancing per ASME Y14.5M-1994.

- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-013 variation AD.



DW (R-PDSO-G24)

PLASTIC SMALL OUTLINE



NOTES:

- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Refer to IPC7351 for alternate board design.
- D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Refer to IPC-7525
- E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.



#### DB (R-PDSO-G\*\*)

#### PLASTIC SMALL-OUTLINE

#### **28 PINS SHOWN**



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-150



SMALL OUTLINE PACKAGE



#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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